

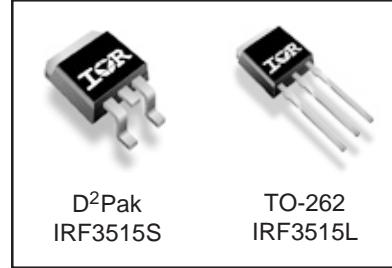
**Applications**

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply
- High speed power switching

<b>V<sub>DSS</sub></b>	<b>R<sub>DS(on)</sub> max</b>	<b>I<sub>D</sub></b>
<b>150V</b>	<b>0.045Ω</b>	<b>41A</b>

**Benefits**

- Low Gate Charge Qg results in Simple Drive Requirement
- Improved Gate, Avalanche and dynamic dv/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Effective Coss Specified (See AN 1001)



**Absolute Maximum Ratings**

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	41	A
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	29	
I <sub>DM</sub>	Pulsed Drain Current ①	164	
P <sub>D</sub> @ T <sub>C</sub> = 25°C	Power Dissipation	200	W
	Linear Derating Factor	1.3	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	± 30	V
dv/dt	Peak Diode Recovery dv/dt ③	4.3	V/ns
T <sub>J</sub> T <sub>STG</sub>	Operating Junction and Storage Temperature Range	-55 to + 175	°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case )	

**Applicable Off Line SMPS Topologies**

- Telcom 48V input DC/DC Active Clamp Reset Forward Converter

Notes ① through ⑤ are on page 10

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Static @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	150	—	—	V	$V_{\text{GS}} = 0\text{V}$ , $I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.21	—	$\text{V}/^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	—	0.045	$\Omega$	$V_{\text{GS}} = 10\text{V}$ , $I_D = 25\text{A}$ ④
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	3.0	—	4.5	V	$V_{\text{DS}} = V_{\text{GS}}$ , $I_D = 250\mu\text{A}$
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	25	$\mu\text{A}$	$V_{\text{DS}} = 150\text{V}$ , $V_{\text{GS}} = 0\text{V}$
		—	—	250		$V_{\text{DS}} = 120\text{V}$ , $V_{\text{GS}} = 0\text{V}$ , $T_J = 150^\circ\text{C}$
$I_{\text{GSS}}$	Gate-to-Source Forward Leakage	—	—	100	$\text{nA}$	$V_{\text{GS}} = 30\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{\text{GS}} = -30\text{V}$

Dynamic @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$g_{\text{fs}}$	Forward Transconductance	15	—	—	S	$V_{\text{DS}} = 50\text{V}$ , $I_D = 25\text{A}$
$Q_g$	Total Gate Charge	—	—	107	nC	$I_D = 25\text{A}$
$Q_{\text{gs}}$	Gate-to-Source Charge	—	—	23		$V_{\text{DS}} = 120\text{V}$
$Q_{\text{gd}}$	Gate-to-Drain ("Miller") Charge	—	—	65		$V_{\text{GS}} = 10\text{V}$ , See Fig. 6 and 13 ④
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	17	—	ns	$V_{\text{DD}} = 75\text{V}$
$t_r$	Rise Time	—	120	—		$I_D = 25\text{A}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	34	—		$R_G = 2.5\Omega$
$t_f$	Fall Time	—	63	—		$R_D = 3.0\Omega$ , See Fig. 10 ④
$C_{\text{iss}}$	Input Capacitance	—	2260	—	pF	$V_{\text{GS}} = 0\text{V}$
$C_{\text{oss}}$	Output Capacitance	—	530	—		$V_{\text{DS}} = 25\text{V}$
$C_{\text{rss}}$	Reverse Transfer Capacitance	—	170	—		$f = 1.0\text{MHz}$ , See Fig. 5
$C_{\text{oss}}$	Output Capacitance	—	3330	—		$V_{\text{GS}} = 0\text{V}$ , $V_{\text{DS}} = 1.0\text{V}$ , $f = 1.0\text{MHz}$
$C_{\text{oss}}$	Output Capacitance	—	230	—		$V_{\text{GS}} = 0\text{V}$ , $V_{\text{DS}} = 120\text{V}$ , $f = 1.0\text{MHz}$
$C_{\text{oss eff.}}$	Effective Output Capacitance	—	280	—		$V_{\text{GS}} = 0\text{V}$ , $V_{\text{DS}} = 0\text{V}$ to $120\text{V}$ ⑤

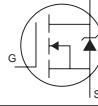
## Avalanche Characteristics

	Parameter	Typ.	Max.	Units
$E_{\text{AS}}$	Single Pulse Avalanche Energy②	—	670	mJ
$I_{\text{AR}}$	Avalanche Current①	—	25	A
$E_{\text{AR}}$	Repetitive Avalanche Energy①	—	20	mJ

## Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta\text{JC}}$	Junction-to-Case	—	0.75	$^\circ\text{C/W}$
$R_{\theta\text{JA}}$	Junction-to-Ambient (PCB Mounted, steady-state)*	—	40	

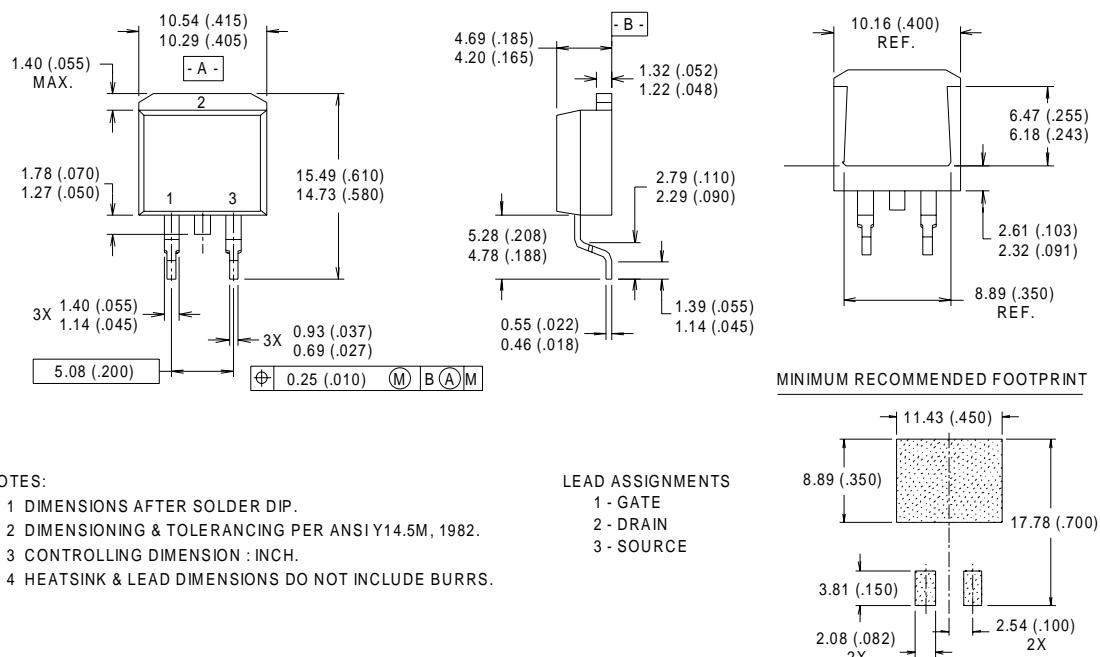
## Diode Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	41	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{\text{SM}}$	Pulsed Source Current (Body Diode) ①	—	—	164		
$V_{\text{SD}}$	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}$ , $I_S = 25\text{A}$ , $V_{\text{GS}} = 0\text{V}$ ④
$t_{\text{rr}}$	Reverse Recovery Time	—	200	300	ns	$T_J = 25^\circ\text{C}$ , $I_F = 25\text{A}$
$Q_{\text{rr}}$	Reverse Recovery Charge	—	1.6	2.4	$\mu\text{C}$	$dI/dt = 100\text{A}/\mu\text{s}$ ④
$t_{\text{on}}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $I_S + L_D$ )				

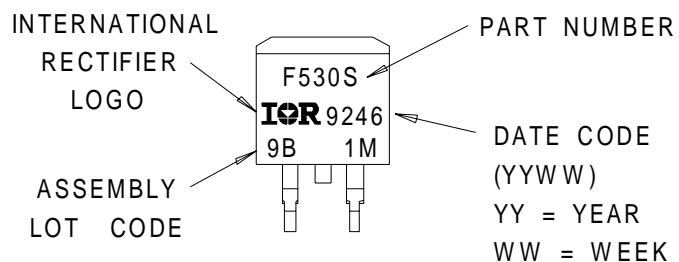
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## D<sup>2</sup>Pak Package Outline



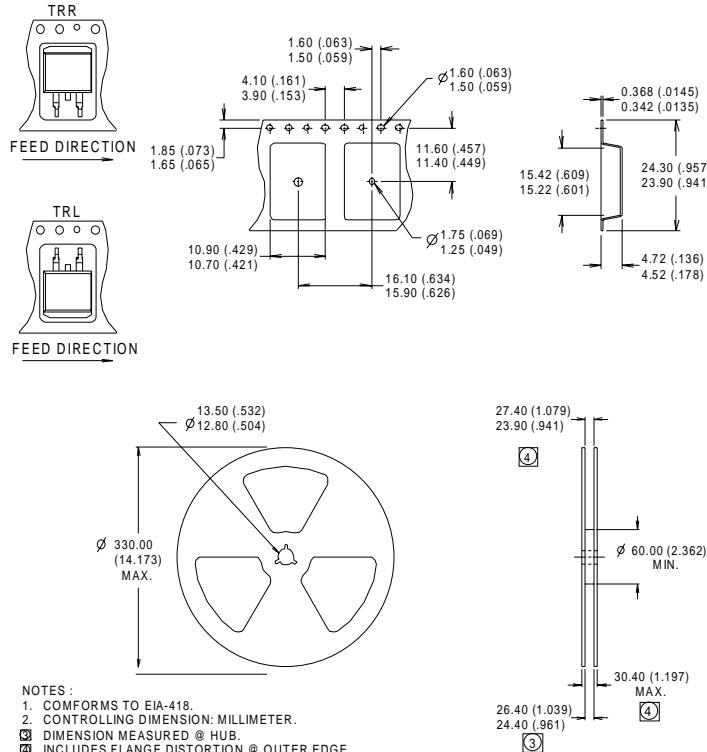
## D<sup>2</sup>Pak Part Marking Information



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## D<sup>2</sup>Pak Tape & Reel Information



### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 2.2\text{mH}$   
 $R_G = 25\Omega$ ,  $I_{AS} = 25\text{A}$ . (See Figure 12)
- ③  $I_{SD} \leq 5.0\text{A}$ ,  $\text{di}/\text{dt} \leq 330\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(\text{BR})DSS}$ ,  
 $T_J \leq 175^\circ\text{C}$
- \* When mounted on FR-4 board using minimum recommended footprint.  
For recommended footprint and soldering techniques refer to application note #AN-994.
- ④ Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ⑤  $C_{oss\ eff}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$

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